

Search Notes

Application/Control No.

10/509,775

Examiner

Steven D. Maki

Applicant(s)/Patent under
Reexamination

MIYABE ET AL.

Art Unit

1733

SEARCHED

Class	Subclass	Date	Examiner
152	209.8		
	209.9		
	209.18		
	209.27		
	209.28		
D12	518		
updated	above	7/16/2007	<i>SDM</i>
152	209.16	7/23/2007	<i>SDM</i>
	209.24		
	523		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
asymmetric and groove cross section digests kept in examiner's office	7/21/2007	<i>SDM</i>